

December 2012

FDMC86260

N-Channel Power Trench[®] MOSFET 150 V, 16 A, 34 m Ω

Features

- Max $r_{DS(on)}$ = 34 m Ω at V_{GS} = 10 V, I_D = 5.4 A
- Max $r_{DS(on)}$ = 44 m Ω at V_{GS} = 6 V, I_D = 4.8 A
- High performance technology for extremely low r_{DS(on)}
- 100% UIL Tested
- Termination is Lead-free
- RoHS Compliant

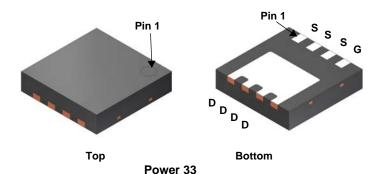
General Description

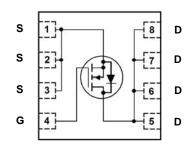
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

■ DC-DC Conversion







MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter				Ratings	Units
V _{DS}	Drain to Source \	Voltage			150	V
V _{GS}	Gate to Source V	/oltage			±20	V
	Drain Current	-Continuous	T _C = 25 °C		16	
I _D		-Continuous	T _A = 25 °C	(Note 1a)	5.4	Α
		-Pulsed			48	
E _{AS}	Single Pulse Ava	lanche Energy		(Note 3)	121	mJ
D	Power Dissipatio	n	T _C = 25 °C		54	10/
P_{D}	Power Dissipation	n	T _A = 25 °C	(Note 1a)	2.3	W
T _J , T _{STG}	Operating and St	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	2.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC86260	FDMC86260	Power33	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		110		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	2.7	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		-9		mV/°C
		$V_{GS} = 10 \text{ V}, I_D = 5.4 \text{ A}$		27	34	
r _{DS(on)}	r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = 6 \text{ V}, I_D = 4.8 \text{ A}$		31	44	mΩ
	$V_{GS} = 10 \text{ V}, I_D = 5.4 \text{ A}, T_J = 125 \text{ °C}$		55	69		
g _{FS}	Forward Transconductance	$V_{DD} = 10 \text{ V}, I_D = 5.4 \text{ A}$		19		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 75.V.V 0.V		1000	1330	pF
Coss	Output Capacitance	$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz		105	140	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1011 12		4.8	10	pF
R_{q}	Gate Resistance		0.1	0.6	1.8	Ω

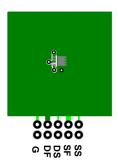
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		9.5	19	ns
t _r	Rise Time	V _{DD} = 75 V, I _D = 5.4 A,	2	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	17	30	ns
t _f	Fall Time		3.3	10	ns
$Q_{g(TOT)}$	Total Gate Charge	V _{GS} = 0 V to 10 V	15	21	nC
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to 6 V}$ $V_{DD} = 75 \text{ V},$	9.7	14	nC
Q_{gs}	Total Gate Charge	I _D = 5.4 A	4.0		nC
Q_{gd}	Gate to Drain "Miller" Charge		3.1		nC

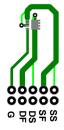
Drain-Source Diode Characteristics

,	Vob Source to Drain Diode Forward voltage F	Source to Drain Diode, Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 5.4 \text{ A}$ (Note 2)		0.77	1.3	V
- []		$V_{GS} = 0 \text{ V}, I_{S} = 1.9 \text{ A}$ (Note 2)		0.72	1.2	V	
t	rr	Reverse Recovery Time	L = 5.4 A di/dt = 100 A/		64	102	ns
(Q _{rr}	Reverse Recovery Charge	I _F = 5.4 A, di/dt = 100 A/μs		85	137	nC

Notes:
1. R_{BJA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. E_{AS} of 121 mJ is based on starting $T_J = 25$ °C, L = 3 mH, $I_{AS} = 9$ A, $V_{DD} = 150$ V, $V_{GS} = 10$ V. 100% test at L = 0.1 mH, $I_{AS} = 22$ A.

Typical Characteristics T_{.1} = 25 °C unless otherwise noted

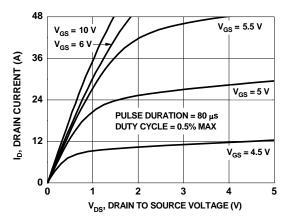


Figure 1. On-Region Characteristics

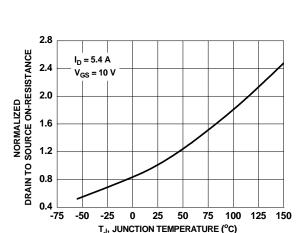


Figure 3. Normalized On-Resistance vs Junction Temperature

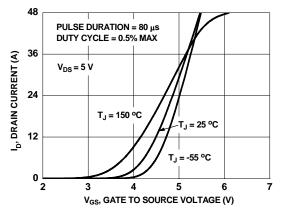


Figure 5. Transfer Characteristics

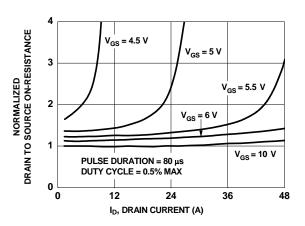


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

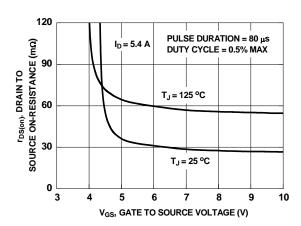


Figure 4. On-Resistance vs Gate to Source Voltage

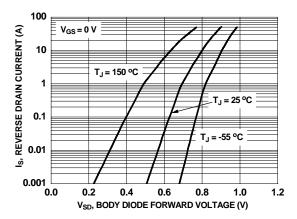


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

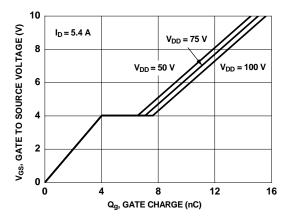


Figure 7. Gate Charge Characteristics

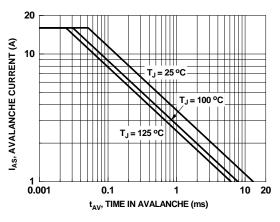


Figure 9. Unclamped Inductive Switching Capability

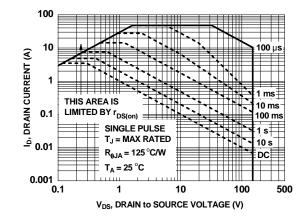


Figure 11. Forward Bias Safe Operating Area

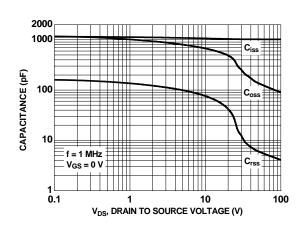


Figure 8. Capacitance vs Drain to Source Voltage

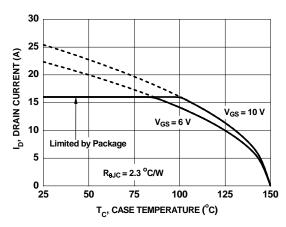


Figure 10. Maximum Continuous Drain Current vs Case Temperature

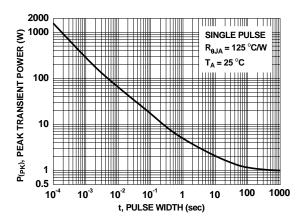


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

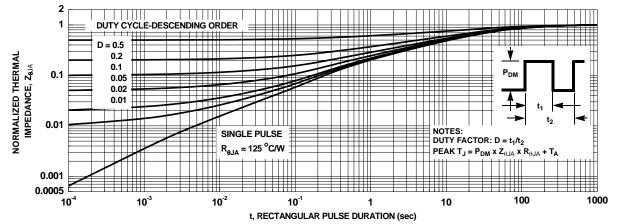
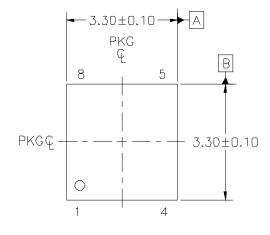
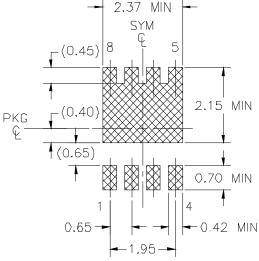


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

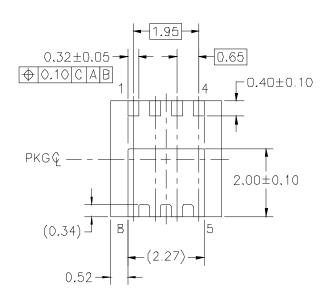
Dimensional Outline and Pad Layout





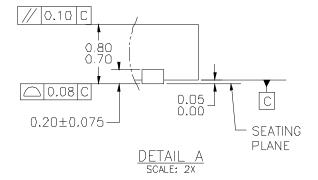
SEE DETAIL A

LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. BA, DATED OCTOBER 2002.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.







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PRODUCT STATUS DEFINITIONS **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information Formative / In Design		Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
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Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 161

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